



SHEET 1 OF 1

Substitute Form PTO-1049

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEDOCKET  
KPO195S.N.  
10/797,731

## INFORMATION DISCLOSURE STATEMENT

APPLICANT  
Aritaka Ohno, et al.FILING DATE  
March 9, 2004GROUP  
2877

## U.S. PATENT DOCUMENTS

*Exam. Initial	Cite No.	DOCUMENT NUMBER Number - Kind Code	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	FILING DATE
		US-			
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## FOREIGN PATENT DOCUMENTS

*Exam. Initial	Cite No.	DOCUMENT NUMBER Number - Kind Code	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	TRANSLATION YES NO	
SAT		JP 2000-513812	10-17-00	JAPAN (corresponding to WO-98/00682)		X
SAT		WO 98/00682	1-8-98	PCT		

## NON-PATENT LITERATURE DOCUMENTS

*Exam. Initial	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	TRANSLATION YES NO	

EXAMINER

S.A. TUANG

DATE CONSIDERED

3-1-06

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP, draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.



SHEET 1 OF 1

Substitute Form PTO-14

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*Exam. Initial	Cite No.	DOCUMENT NUMBER Number - Kind Code	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	TRANSLATION YES NO	
SAT		WO-03/060427-A1	7-24-2003	PCT		
↑		DE 195 02 519 A1	8-8-96	Germany, with English abstract		X
↓		EPO 0 760 461 A1	3-5-97	European Patent Office		
SAT		EPO 0 260 885 A2	3-23-88	European Patent Office		

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**Aritaka Ohno, et al.**

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## U.S. PATENT DOCUMENTS

[illegible]

## FOREIGN PATENT DOCUMENTS

[illegible]

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, etc.)

SAT		Ohno, Aritaka, et al., "Intermediate and moderate grade Fiber Optic Gyroscope for industrial applications," SPIE Vol. 2292 Fiber Optic and Laser Sensors XII (1994), pp. 166-176
		Usui, Ryuji, et al., "Intermediate Grade FOG with Single Mode Fiber Coil," SPIE Vol. 2070 Fiber Optic and Laser Sensors XI (1993), pp. 152-163

**EXAMDNER**

5.A. Tanager

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